

<b>Search Notes</b> 				<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
				10/759,766	WALSH ET AL.	
				Examiner	Art Unit	
				TAN TRINH	2618	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
455	427	9/11/2006	TT	EAST	9/11/2006	TT
	12.1					
	430					
	13.1					
	431					
	13.2					
	429					
	436					
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			